

**Notice of References Cited**

Application/Control No.

10/564,852

Applicant(s)/Patent Under  
Reexamination  
ABE ET AL.

Examiner

/Laura S. Weiner/

Art Unit

1795

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,927,001	08-2005	Hamamoto et al.	429/331
	C	US-			
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	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	O				translation only	
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	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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